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Applied AI-Based Platform Technology and Application, Volume II

Guest Editor:

Prof. Dr. Taeshik Shon

Department of Software and Computer Engineering, Ajou University, Suwon 16499, Republic of Korea

Deadline for manuscript submissions:

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Message from the Guest Editor

Dear Colleagues,

This Special Issue aims to encourage the most recent and advanced research in platform technology and application, with a special focus on their practical applications to science, engineering, industry, medicine, robotics, manufacturing, entertainment, optimization, business, and other fields. We kindly invite researchers and practitioners to contribute their high-quality original research or review articles on these topics to this Special Issue.

Topics appropriate for this Special Issue include but are not necessarily limited to:

- Machine-learning-based platform technology and application;
- Clustering and classification of industrial data processing;
- Industrial AI-based applications for platform technology and application;
- Al security, trust, assurance, and resilience;
- Digital forensics for platform technology and application;
- Multimedia and distributed systems for platform technology;
- Smart home and M2M network for platform technology;
- Scientific and big data visualization platform;
- Business management and intelligence;
- Security and privacy issues in emerging platforms.



Specialsue







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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

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